FDMC4D9P20X8

P-Channel Power Trench® MOSFET

−20 V, −75 A, 4.9 mΩ

ON Semiconductor®

www.onsemi.com

General Description

This P−Channel MOSFET is produced using ON Semiconductor's advanced PowerTrench® process that has been optimized for $r_{DS(on)}$, switching performance and ruggedness.

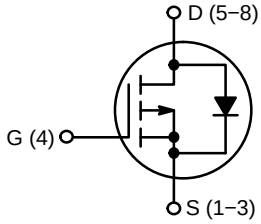
Features

- Max $r_{DS(on)}$ = 4.9 mΩ at V_{GS} = −4.5 V, I_D = −18 A
- Max $r_{DS(on)}$ = 16.4 mΩ at V_{GS} = −1.8 V, I_D = −9 A
- High Performance Trench Technology for Extremely Low $r_{DS(on)}$
- High Power and Current Handling Capability in a Widely Used Surface Mount Package
- These Devices are Pb−Free, Halogen Free/BFR Free and are RoHS Compliant

Applications

- Load Switch
- Battery Management
- Power Management
- Reverse Polarity Protection

V_{DS}	$R_{DS(ON)}$ MAX	I_D MAX
−20 V	4.9 mΩ @ −4.5 V	−75 A
	6.5 mΩ @ −2.5 V	
	16.4 mΩ @ −1.8 V	



P-Channel MOSFET

Top Bottom

PQFN8
CASE 483AX

MAXIMUM RATINGS (T_A = 25°C unless otherwise noted)

Symbol	Parameter	Ratings	Units
V_{DS}	Drain to Source Voltage	−20	V
V_{GS}	Gate to Source Voltage	±12	V
I_D	Drain Current: Continuous, T_C = 25°C (Note 5) Continuous, T_C = 100°C (Note 5) Continuous, T_A = 25°C (Note 1a) Pulsed (Note 4)	 −75 −47 −18 −335	A
E_{AS}	Single Pulse Avalanche Energy (Note 3)	54	mJ
P_D	Power Dissipation: T_C = 25°C T_A = 25°C (Note 1a)	 40 2.4	W
T_J, T_{STG}	Operating and Storage Junction Temperature Range	−55 to +150	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

MARKING DIAGRAM

$Y	= ON Semiconductor Logo
&Z	= Assembly Plant Code
&3	= Data Code (Year & Week)
&K	= Lot
FDMC4D9P20X8	= Specific Device Code

ORDERING INFORMATION

See detailed ordering and shipping information on page 3 of this data sheet.

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THERMAL CHARACTERISTICS

Symbol	Parameter	FDMC4D9P20X8	Unit
$R_{\theta JC}$	Thermal Resistance, Junction to Case	3.1	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Note 1a)	53	

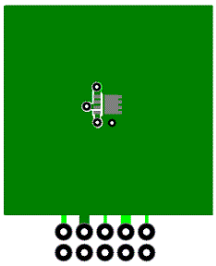
ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted)

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Units
OFF CHARACTERISTICS						
BV_{DSS}	Drain to Source Breakdown Voltage	I_D = −250 μA, V_{GS} = 0 V	−20			V
$\Delta BV_{DSS}/\Delta T_J$	Breakdown Voltage Temperature Coefficient	I_D = −250 μA, Referenced to 25 °C		−15		mV/°C
I_{DSS}	Zero Gate Voltage Drain Current	V_{DS} = −16 V, V_{GS} = 0 V			−1	μA
I_{GSS}	Gate to Source Leakage Current	V_{GS} = ±12 V, V_{DS} = 0 V			±100	nA
ON CHARACTERISTICS						
$V_{GS(th)}$	Gate to Source Threshold Voltage	V_{GS} = V_{DS}, I_D = −250 μA	−0.4	−0.7	−1.6	V
$\Delta V_{GS(th)}$ ΔT_J	Gate to Source Threshold Voltage Temperature Coefficient	I_D = −250 μA, referenced to 25 °C		4		mV/°C
$r_{DS(on)}$	Static Drain to Source On Resistance	V_{GS} = −4.5 V, I_D = −18 A		3.3	4.9	mΩ
		V_{GS} = −2.5 V, I_D = −11 A		4.1	6.5	
		V_{GS} = − 1.8 V, I_D = −9 A		6.2	16.4	
		V_{GS} = −4.5 V, I_D = −18 A, T_J = 125 °C		4.5	6.8	
g_{FS}	Forward Transconductance	V_{DS} = −5 V, I_D = −18 A		113		S
DYNAMIC CHARACTERISTICS						
C_{iss}	Input Capacitance	V_{DS} = −10 V, V_{GS} = 0 V, f = 1 MHz		7535	10550	pF
C_{oss}	Output Capacitance			1100	1540	pF
C_{rss}	Reverse Transfer Capacitance			1040	1455	pF
R_g	Gate Resistance		0.1	4.5	10	Ω
SWITCHING CHARACTERISTICS						
$t_{d(on)}$	Turn-On Delay Time	V_{DD} = −10 V, I_D = −18 A, V_{GS} = −4.5 V, R_G = 6 Ω		13	23	ns
t_r	Rise Time			17	31	ns
$t_{d(off)}$	Turn-Off Delay Time			312	499	ns
t_f	Fall Time			176	282	ns
Q_g	Total Gate Charge	V_{GS} = 0 V to −4.5 V, V_{DD} = −10 V, I_D = −18 A		78	109	nC
		V_{GS} = 0 V to −2.5 V, V_{DD} = −10 V, I_D = −18 A		50	70	nC
Q_{gs}	Gate to Source Charge	V_{DD} = −10 V, I_D = −18 A		12		nC
Q_{gd}	Gate to Drain “Miller” Charge	V_{DD} = −10 V, I_D = −18 A		24		nC
DRAIN−SOURCE DIODE CHARACTERISTICS						
V_{SD}	Source to Drain Diode Forward Voltage	V_{GS} = 0 V, I_S = −18 A (Note 2)		−0.7	−1.2	V
		V_{GS} = 0 V, I_S = −2 A (Note 2)		−0.6	−1.2	
t_{rr}	Reverse Recovery Time	I_S = −18 A, di/dt = 100 A/μs		41	66	ns
Q_{rr}	Reverse Recovery Charge			22	35	nC

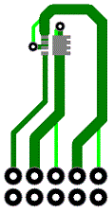
Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

1. $R_{\theta JA}$ is determined with the device mounted on a 1 in^2 pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR−4 material. $R_{\theta CA}$ is determined by the user's board design.

NOTES:



a) 53 °C/W when mounted on a 1 in^2 pad of 2 oz copper.



b) 125 °C/W when mounted on a minimum pad of 2 oz copper.

2. Pulse Test: Pulse Width < 300 μs, Duty cycle < 2.0 %
3. E_{AS} of 54 mJ is based on starting T_J = 25 C, L = 3 mH, I_{AS} = −6 A, V_{DD} = − 20 V, V_{GS} = −10 V.
4. Pulsed Id please refer to Fig 11 SOA graph for more details.
5. Computed continuous current limited to Max Junction Temperature only, actual continuous current will be limited by thermal & electro−mechanical application board design.

PACKAGE MARKING AND ORDERING INFORMATION

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDMC4D9P20X8	FDMC4D9P20X8	PQFN8 (Pb Free)	13”	12 mm	3000 Units

TYPICAL CHARACTERISTICS

(T_J = 25 °C unless otherwise noted)

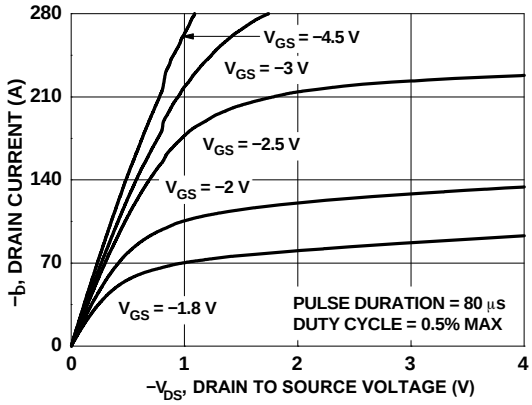


Figure 1. On−Region Characteristics

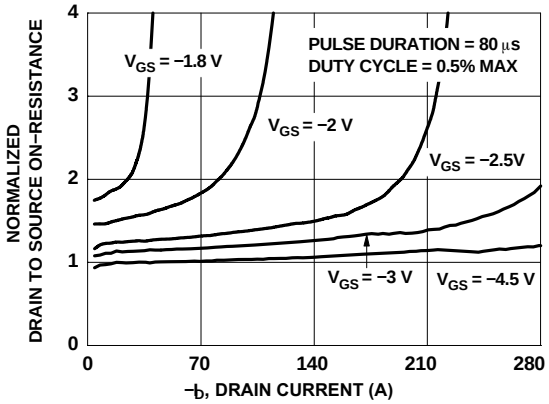


Figure 2. Normalized On−Resistance vs Drain Currentand Gate Voltage

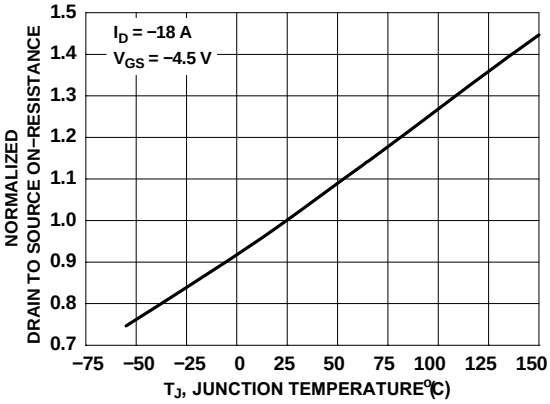


Figure 3. Normalized On−Resistance vs Junction Temperature

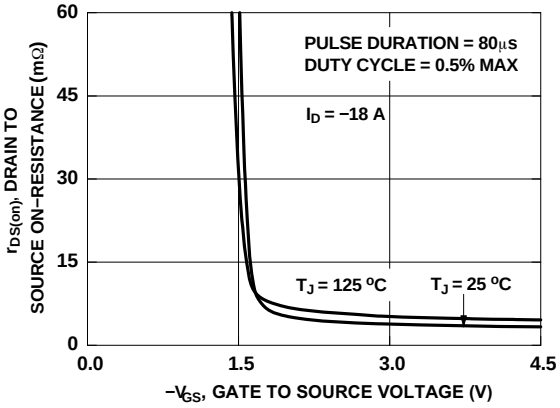


Figure 4. On−Resistance vs Gate to Source Voltage

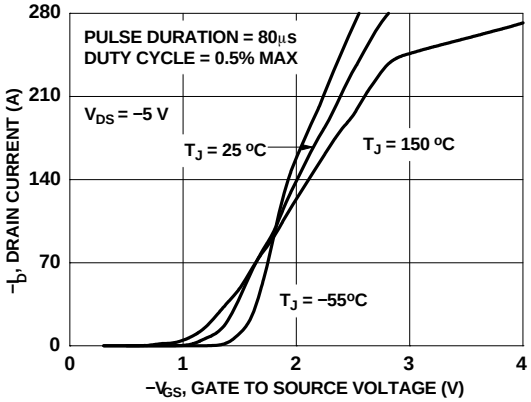


Figure 5. Transfer Characteristics

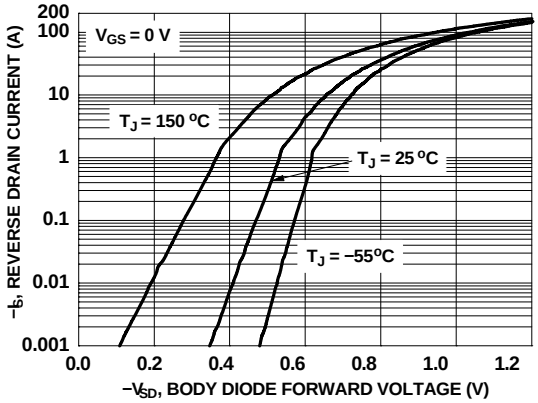


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

TYPICAL CHARACTERISTICS

(T_J = 25 °C unless otherwise noted)

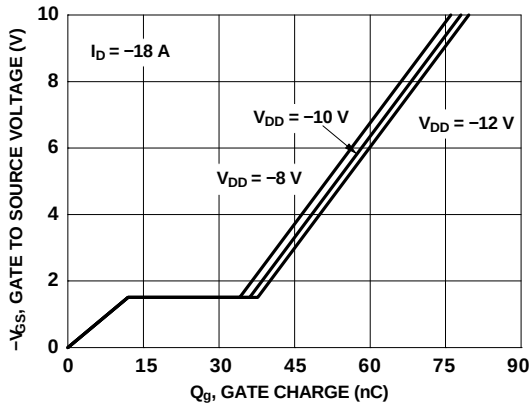


Figure 7. Gate Charge Characteristics

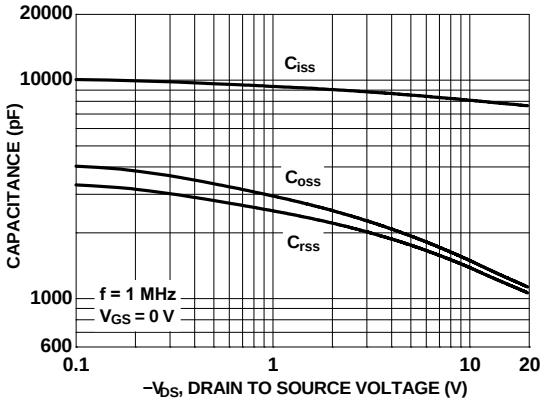


Figure 8. Capacitance vs Drain to Source Voltage

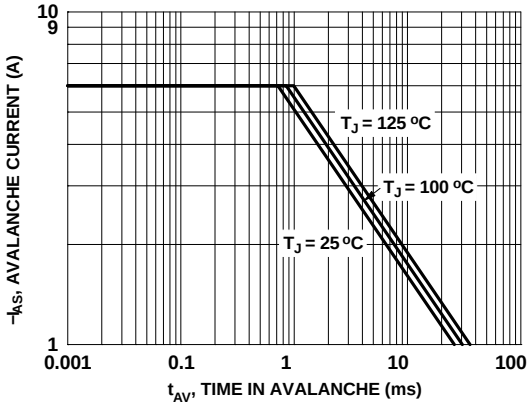


Figure 9. Unclamped Inductive Switching Capability

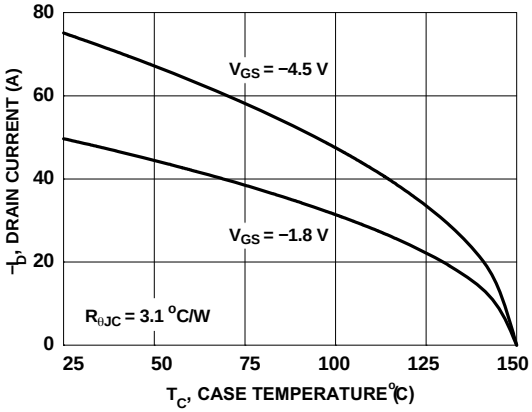


Figure 10. Maximum Continuous Drain Current vs Case Temperature

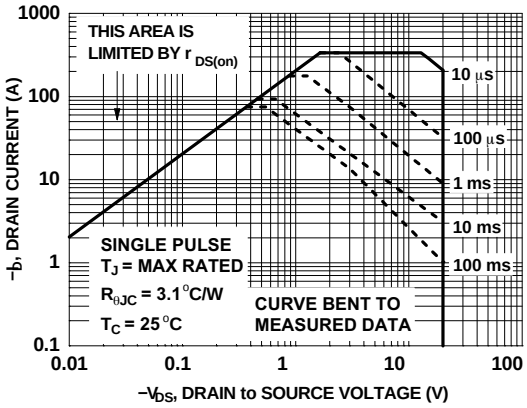


Figure 11. Forward Bias Safe Operating Area

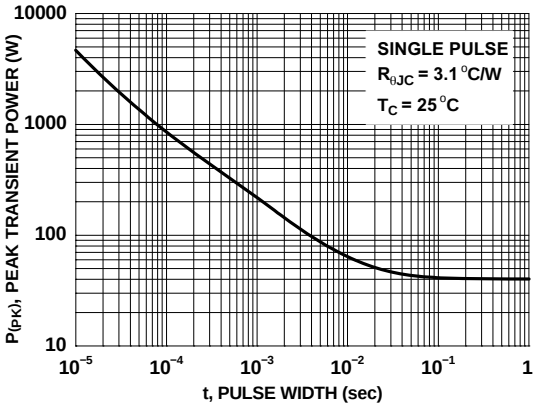


Figure 12. Single Pulse Maximum Power Dissipation

TYPICAL CHARACTERISTICS

(T_J = 25 °C unless otherwise noted)

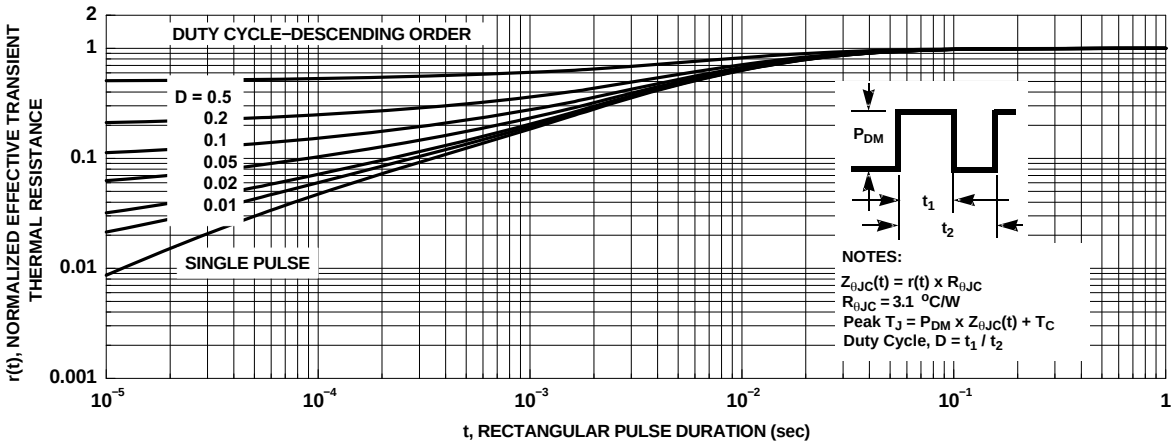


Figure 13. Junction−to−Case Transient Thermal Response Curve

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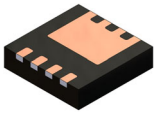

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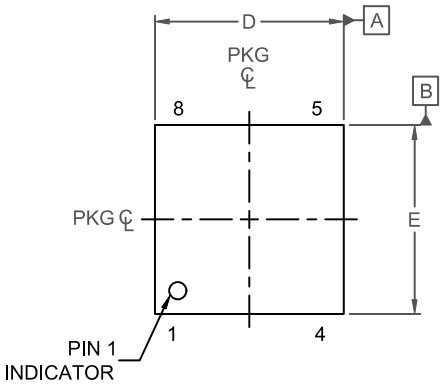
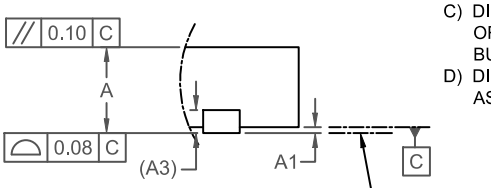
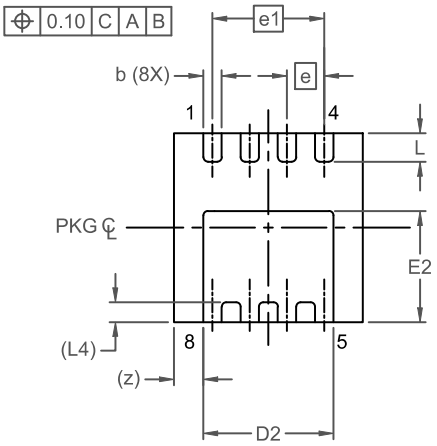
CASE 483AX
ISSUE A

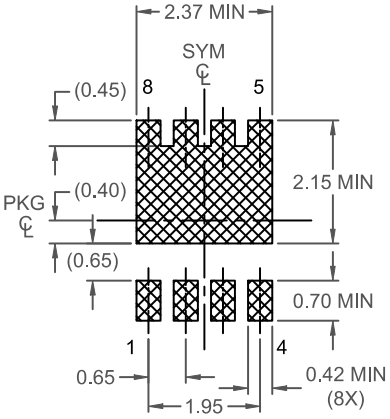
DATE 18 MAY 2021





DETAIL A
SCALE: 2X





LAND PATTERN
RECOMMENDATION

*FOR ADDITIONAL INFORMATION ON OUR PB-FREE STRATEGY AND SOLDERING DETAILS, PLEASE DOWNLOAD THE ON SEMICONDUCTOR SOLDERING AND MOUNTING TECHNIQUES REFERENCE MANUAL, SOLDERRM/D.

NOTES: UNLESS OTHERWISE SPECIFIED

A) PACKAGE STANDARD REFERENCE: JEDEC MO-240, ISSUE A, VAR. BA,
B) ALL DIMENSIONS ARE IN MILLIMETERS.
C) DIMENSIONS DO NOT INCLUDE BURRS OR MOLD FLASH. MOLD FLASH OR BURRS DOES NOT EXCEED 0.10MM.
D) DIMENSIONING AND TOLERANCING PER ASME Y14.5M-2009.

DIM	MILLIMETERS		
	MIN.	NOM.	MAX.
A	0.70	0.75	0.80
A1	0.00	-	0.05
A3	0.20 REF		
b	0.27	0.32	0.37
D	3.20	3.30	3.40
D2	2.17	2.27	2.37
E	3.20	3.30	3.40
E2	1.79	1.89	1.99
e	0.65 BSC		
e1	1.95 BSC		
L	0.40	0.50	0.60
L4	0.34 REF		
z	0.52 REF		

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DESCRIPTION:	**PQFN8 3.3X3.3, 0.65P**	**PAGE 1 OF 1**

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